

## IN THE U.S. PATENT AND TRADEMARK OFFICE

May 30, 2006

Applicant(s) : Baolin TAN et al.  
 For : DIGITAL PROCESSING DISRUPTION SYSTEMS  
 PCT International Application No.: PCT/GB2004/002415  
 PCT International Filing Date: June 7, 2004  
 U.S. Application No.  
 (if known, see 37 CFR 1.5): 10/559 715  
 Atty. Docket No.: 3700.P0406US  
 Mail Stop PCT  
 Commissioner for Patents  
 P.O. Box 1450  
 Alexandria, VA 22313-1450

## INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(3) and 1.98, enclosed herewith is a copy of the International Search Report for the patent application corresponding to the present application, Form PTO-1449 and copies of the foreign cited patent documents.

A copy of cited U.S. reference is not submitted in accordance with 37 CFR 1.98(a).

The relevance of the enclosed references is explained in column 1 "Category" on the enclosed International Search Report. Further comment at this point in time should not be necessary.

Further consideration is respectfully solicited.

Respectfully submitted,



Liane L. Churney

LLC/ad

FLYNN, THIEL, BOUTELL  
 & TANIS, P.C.  
 2026 Rambling Road  
 Kalamazoo, MI 49008-1631  
 Phone: (269) 381-1156  
 Fax: (269) 381-5465

Dale H. Thiel  
 David G. Boutell  
 Terryence F. Chapman  
 Mark L. Maki  
 Liane L. Churney  
 Brian R. Tumm  
 Steven R. Thiel  
 Donald J. Wallace  
 Sidney B. Williams, Jr.

Reg. No.	24	323
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Reg. No.	43	977
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Encl: International Search Report  
 Form PTO-1449  
 One copy of each foreign patent document

INFORMATION DISCLOSURE CITATION	Applicant: Baolin TAN et al.
	Ser.No.: 10/559 715      Filed: Unknown
	Conf. No.: Unknown      Atty. Docket No.: 3700.P0406US
	Group: Unknown      Date: May 30, 2006

## U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA	6 188 832 B1	02-13-2001	Ryan
	AB			
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	AD			
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## FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
	AL	WO01/74068 A1	10-04-2001	Macrovision Corporation	
	AM	WO03/065716 A2	02-03-2003	Dwight Cavendish Systems Limited	
	AN				
	AO				
	AP				

## NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	(Include Author, Title, Date, Pages, Etc.)
	AQ	
	AR	
EXAMINER SIGNATURE		DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.